

# Reliability of Mechatronics Systems

## Resources

### Reference books

Ang, A. H-S., and W. H. Tang. *Probability Concepts in Engineering Planning and Design*, vol. 1, *Basic Principles*. New York, NY: John Wiley & Sons, 1975.

Rausand, M., and A. Hoyland. *System Reliability Theory: Models, Statistical Methods, and Applications*. 2nd ed. New York, NY: John Wiley & Sons, 2003

G. Habchi and C. Barthod, *An overall methodology for reliability prediction of mechatronic systems design with industrial application*. Reliability Engineering & System Safety, 155 (2016), 236-254.

### Website

<https://www.weibull.com>.

## Recall of Basic Probability Theory and Statistics

### Important Terms

**Probability density function (pdf)** – A continuous representation of a histogram that shows how the number of component failures are distributed in time.

**Cumulative distribution function (cdf)** – Also called the probability of failure, represents the probability that a brand new component will fail at or before a specified time.

From probability and statistics, given a **continuous random variable**  $X$ , we denote:

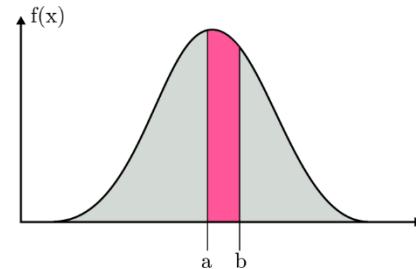
- The probability density **PDF**, as  $f(x)$ .
- The cumulative distribution **CDF**, as  $F(x)$ .
- The **pdf** and **cdf** give a complete description of the probability distribution of a random variable.

### Probability density function (pdf)

If  $X$  is a continuous random variable, then the probability density function, pdf, of  $X$  is a function  $f(x)$  such that for two numbers,  $a$  and  $b$  with  $a \leq b$ :

$$P(a \leq X \leq b) = \int_a^b f(x) dx$$

In other words, the pdf defines the probability that  $X$  takes on a value in the interval  $[a,b]$  is the area under the density function from  $a$  to  $b$ . This is represented graphically in the following plot.



In reliability terms, this function gives us the probability that a failure occurs between time  $a$  and time  $b$ . This function completely describes the distribution, and is the basis for almost all of the familiar reliability and life data functions.

Properties of a density function:

- Must be positive. Obviously a probability cannot be a negative value
- Must be continuous by definition.
- The area under the entire curve must be equal to 1 (as the sum of the probabilities values of a law must be equal to 1).

### Example to better understand PDF

Take the example of heights of students in a class. Let's say that the height of all the students is between 160 cm and 170 cm. It makes no sense to ask the probability that the height of the student is EXACTLY 165.84 cm; that probability is zero. We can, however, define the probability that the height of the student lies in the infinitesimal interval [163;166] cm for example. The function that gives this probability density is referred to as the probability density function or *pdf*.

### Cumulative distribution function (cdf)

The cumulative distribution function, cdf, is a function  $F(x)$  of a random variable  $X$ , and is defined for a number  $x$  by:

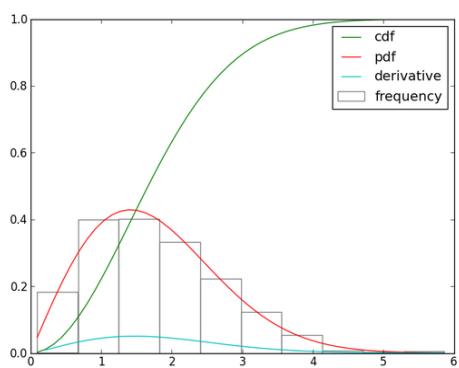
$$F(x) = P(X \leq x) = \int_{0,-\infty}^x f(s) ds$$

That is, for a given value  $x$ ,  $F(x)$  is the probability that the observed value of  $X$  will be at most  $x$ . Evaluated at  $x$ , is the probability that  $X$  will take a value less than or equal to  $x$ .

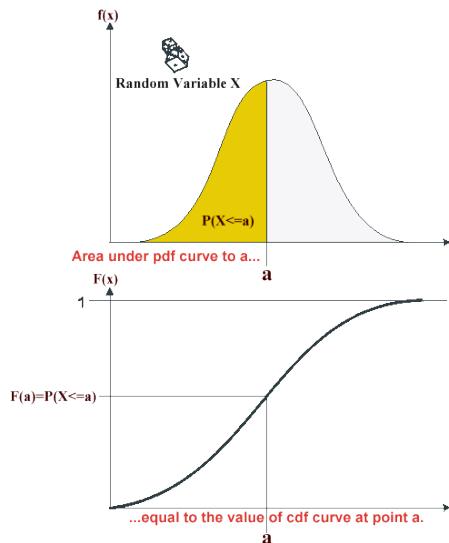
The cumulative distribution function,  $F(x)$ , denotes the area beneath the probability density function to the left of  $x$ .

### PDF and CDF relationship

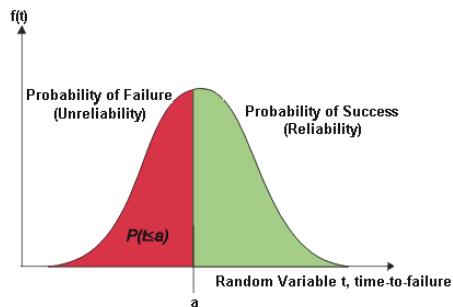
Probability looks at probability at one point, while Cumulative is the total probability of anything below it. As you can see in the diagram below, the cumulative is much greater than the just probability because it is the sum of many, and not just of one probabilities.



Following is a graphical representation of the relationship between the PDF and CDF.



The following figure illustrates the relationship between the reliability function and the CDF, or the unreliability function.



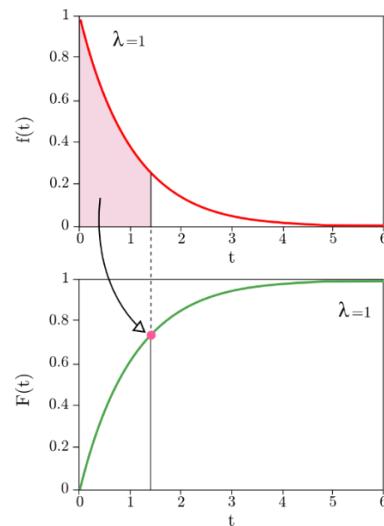
### Example with the exponential distribution

The probability density function (PDF) of exponential distribution is:

$$f(t) = \lambda e^{-\lambda t}$$

The exponential cumulative distribution function can be derived from its PDF as follows :

$$F(t) = \int_0^t f(t) dt = \int_0^t \lambda e^{-\lambda t} dt = \lambda \left[ \frac{e^{-\lambda t}}{-\lambda} \right]_0^t = \lambda \left[ \frac{e^{-\lambda t}}{-\lambda} - \frac{1}{-\lambda} \right] = 1 - e^{-\lambda t}$$



$F(t)$  in this particular case with the exponential distribution, is the Failure function of a product when the failure rate is constant. The failure density is linked to the failure rate by the following relation:  $f(t) = \lambda(t) \cdot [1 - F(t)]$ . Details are provided further.

### Important Terms

**Quality** – Conformance to specifications or requirements defined by customer at time  $t = 0$  (Quality is not binary rather a continuous structure between good and bad)

**Failure** – The number of failures per unit time that can be expected to occur for the product.

**Lifetime** – A statistical measure (or estimate) of how long a product is expected to perform its intended functions under a specific set of environmental, electrical and mechanical conditions. Lifetime specifications can only describe the behaviour of a population; any single product may fail before or after the rated lifetime.

**Mean Time Between Failures (MTBF)** – The average time between failures during useful life for repairable or redundant systems.

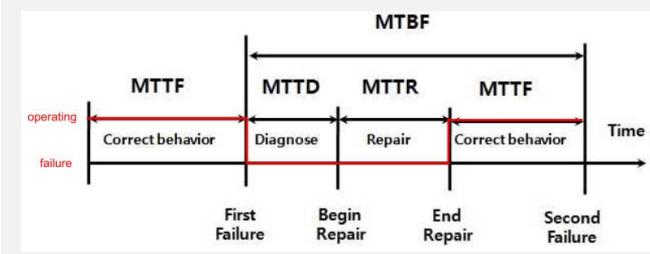
**Mean Time To Failure (MTTF)** – The average time to failure during useful life for components or non-repairable systems.

**Reliability** – A statistical measure (or estimate) of the ability of a product to perform its intended functions under a specific set of environmental, electrical, and mechanical conditions, for a specific period of time. Reliability estimates for the entire useful life phase of a product are commonly reported using MTBF or MTTF.

**Maintainability** – Ability of an item, under stated conditions of use, to be retained in, or restored to, a state in which it can perform its required functions, when maintenance is performed under stated conditions and using prescribed procedures and resources

**Serviceability** – The ability of a product to be repaired by regular maintenance personnel, typically through replacement of a subsystem or one or more associated components

**Availability** – probability that a product or system is in operation at a specified time



## Reliability Functions

The term "reliability" in engineering refers to the probability that a product, or system, will perform its designed functions under a given set of operating conditions for a specific period of time. It is also known as the "probability of survival".

Reliability is defined as the probability that an individual unit of the product, operating under specified conditions, will work correctly for a specified length of time. Hence reliability is the probability of failure in the flat central part of the familiar bathtub curve shown below.

Several distributions defined by parameters are commonly used for reliability models, including:

- Exponential
- Weibull
- Gamma
- normal (Gaussian)
- log-normal
- log-logistic.

The choice of parametric distribution for a particular application can be made using graphical methods or using formal tests of fit.

The **exponential law** is well adapted when the **failure rate ( $\lambda$ ) is constant**, (i.e. it is independent of time). The **normal law** represents behaviours where the **lifetime of the population is homogeneous**, the probability of failure is centred and symmetrical. It can be used to model maturity behaviour (without breakdowns) and then rapid wear and tear. The **Weibull's law** models **each of the three phases** of a material's life. It generalises the two previous laws but is more difficult to use and interpret.

Technology	Comments	Reliability distribution and parameters
Electronics	Known distribution and parameters available in Database	<b>EXPONENTIAL LAW</b> MTTF or $\lambda$ (failure rate)
Mechanics	Distribution are known for few standard elements To find for most of specific components	<b>WEIBULL LAW</b> <ul style="list-style-type: none"> <li>▪ <math>b</math> (shape parameter)</li> <li>▪ <math>h</math> (scale parameter)</li> </ul>

### Failure rate : $\lambda(t)$

A way to look at the failure behaviour in time is to examine the failure rate. Failure rate is function of time. For instance, over a year, a bearing used in a car might have a higher failure rate in summer than in winter.

Failure rates can be expressed using any measure of time, but **hours** is the most common unit in practice. Other units, such as km, revolutions, etc., can also be used in place of "time" units.

Mathematically, the failure rate function is a conditional form of the pdf:

$$\lambda(t) = \frac{f(t)}{R(t)}$$

under the condition is that no failure has occurred before time  $t$ .

then:

$$\lambda(t) = \frac{R(t_1) - R(t_2)}{(t_2 - t_1) \cdot R(t_1)} = \frac{R(t) - R(t + \Delta t)}{\Delta t \cdot R(t)}$$

over a time interval  $\Delta t = (t_2 - t_1)$  from  $t_1$  (or  $t$ ) to  $t_2$ .

### Exponential model (Constant Failure Rate: $\lambda(t) = \lambda_0$ )

The exponential distribution is the most widely used distribution in reliability and risk. It is used when the failure rate is **constant** for all times:  $\lambda(t) = \lambda_0$ . It is often referred to as "**failure rate on average**". The corresponding reliability and probability density function are exponential functions given by:

$$R(t) = e^{(-\lambda_0 \cdot t)}$$

$$f(t) = \lambda_0 \cdot e^{(-\lambda_0 \cdot t)}$$

The mean time to failure is readily obtained as:

$$MTTF = E(t) = \frac{1}{\lambda_0}$$

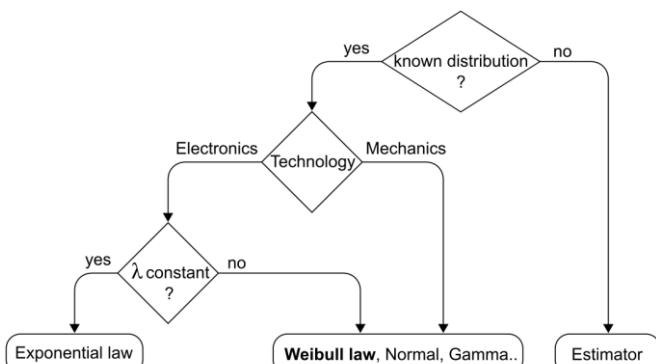
While MTBF can be a useful metric to estimate reliability, especially when comparing components from multiple vendors, the trap many people fall into is wrongly assuming that the MTBF figure directly equates to the expected life of the component.

### Weibull model

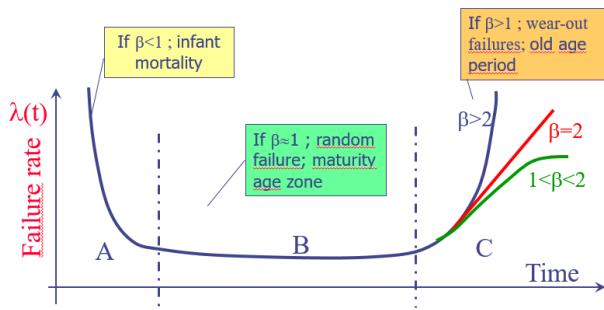
Named after the Swedish professor Waloddi Weibull (1887-1979), the Weibull distribution is one of the most widely used life distributions in reliability analysis.

Weibull analysis is able to answer many life cycle engineering problems such as mean life estimation, reliability of products at any operational time and warranty cost estimation etc. The advantages of Weibull model in life data analysis can be extended to facilitate decision-making processes in many remanufacturing practices such as prediction of the number of cores returned for remanufacturing, estimation of spare parts or remedy resources needed for each failure mode, and so on.

This curve is usually called a bathtub curve after its characteristic shape. The failure rate is often high in the initial phase. This can be explained by the fact that there may be undiscovered defects (known as "infant mortality") in the items; these soon show up when the items are activated. In the early life of a product, the failure rate decreases as defective products are identified and discarded, and early sources of potential failure such as manufacturing defects or damage during transit are detected. When the item has survived the infant mortality period, the failure rate often stabilizes at a level where it remains for a certain amount of time until it starts to increase as the items begin to



wear out. From the shape of the bathtub curve, the lifetime of an item may be divided into three typical intervals: the burn-in period, the useful life period and the wear-out period.



The Weibull distribution has three parameters:

- Shape parameter  $\beta$  (beta)
- Scaling parameter  $\eta$  (eta)
- Position parameter  $\gamma$  (gamma)

Among the two parameters, the slope of the Weibull distribution,  $\beta$ , is very important as it determines which member of the family of Weibull failure distributions best fits or describes the data. It also indicates the class of failures in the "bathtub curve" failure modes.

#### Shape parameter $\beta$

The Weibull shape parameter  $\beta$  indicates whether the failure rate is increasing, constant or decreasing.

- $\beta < 1$  indicates infant mortality;
- $\beta = 1$  means random failures (i.e. independent of time);
- $\beta > 1$  indicates wear-out failures.

The information about the  $\beta$  value is extremely useful for reliability centered maintenance planning and product life cycle management. This is because it can provide a clue to the physics of the failures and tell the analyst whether or not scheduled inspections and overhauls are needed. For instance, if  $\beta$  is less than or equal to one, overhauls are not cost effective. With  $\beta$  greater than one, the overhaul period or scheduled inspection interval can be read directly from the plot at an acceptable or allowable probability of failures. For wear-out failure modes, if the cost of an unplanned failure is much greater than the cost of a planned replacement, there will be an optimum replacement interval for minimum cost.

#### Scale parameter $\eta$

The scale parameter, or spread,  $\eta$ , sometimes also called the characteristic life, represents the typical time-to-failure in Weibull analysis. It is related to the Mean-Time-to-Failure (MTTF). In Weibull analysis,  $\eta$  is defined as the time at which 63.2% of the products will have failed

#### Location parameter $\gamma$

It is expressed in units of time. It indicates the date of the occurrence of the failure mode characterised by  $\beta$ .

### Weibull functions

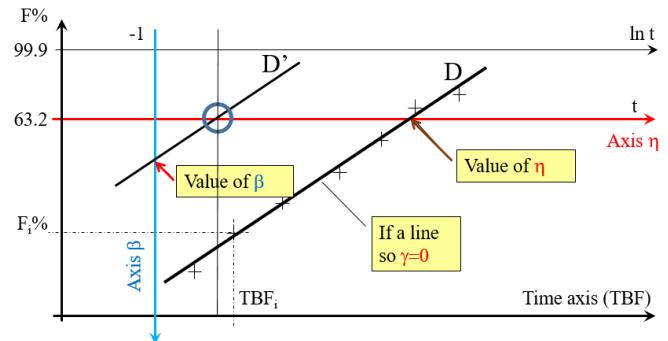
Reliability	$R(t) = e^{-\left(\frac{t-\gamma}{\eta}\right)^\beta}$
Failure	$F(t) = 1 - R(t) = 1 - e^{-\left(\frac{t-\gamma}{\eta}\right)^\beta}$
Failure probability density	$f(t) = \frac{dF(t)}{dt} = \frac{\beta}{\eta} \left(\frac{t-\gamma}{\eta}\right)^{\beta-1} e^{-\left(\frac{t-\gamma}{\eta}\right)^\beta}$

### Weibull paper's graphics method

1. Sort the data table from the smallest to the largest TTF or TBF.

2. Estimate the failure function  $F(t)$  for each unit.

3. Put the points of coordinates  $(t, F(t))$  on the Weibull paper



$$MTBF = A \eta + \gamma$$

(A can be found from the Weibull table)

$\beta$	A	B	$\beta$	A	B	$\beta$	A	B
			1,50	0,9027	0,613	4	0,9064	0,254
			1,55	0,8994	0,593	4,1	0,9077	0,249
			1,60	0,8966	0,574	4,2	0,9089	0,244
			1,65	0,8942	0,556	4,3	0,9102	0,239
0,20	120	1901	1,70	0,8922	0,540	4,4	0,9114	0,235
0,25	24	199	1,75	0,8906	0,525	4,5	0,9126	0,230
0,30	9,2605	50,08	1,80	0,8893	0,511	4,6	0,9137	0,226
0,35	5,0291	19,98	1,85	0,8882	0,498	4,7	0,9149	0,222
0,40	3,3234	10,44	1,90	0,8874	0,486	4,8	0,9160	0,218

### Conditional Reliability Function

Conditional reliability is defined as the probability that a component or system will operate without failure for a mission time,  $t$ , given that it has already survived to a given time,  $T$ .

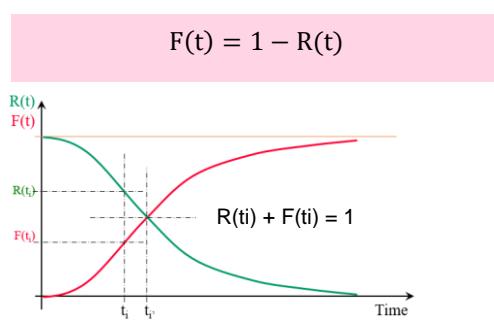
Mathematically, this is expressed as:

$$R(t|T) = \frac{R(t+T)}{R(T)}$$

Remark:  $R(t|T) = \frac{e^{-\lambda(t+T)}}{e^{-\lambda T}} = e^{-\lambda t} = R(t)$

The survivor function of an item that has been functioning for  $t$  time units is therefore equal to the survivor function of a new item. A new item, and a used item (that is still functioning), will therefore have the same probability of surviving a time interval of length  $t$ .

### Failure Function



## Reliability Estimators

It is obviously not realistic to calculate failure rates by building many units and running them for many hours, under expected operating conditions. This is especially true for well-designed and properly built supplies, with extremely low failure rates, where the number of supplies and hours required to get valid results would be in the thousands. Instead based on representative samples of a population statistical analysis techniques can be used to estimate failure rates.

If you don't know the failure law on which your component is based, then use estimators.

### Important Terms

**N** – total number of products put into operation at time  $t_0$  (sample size)

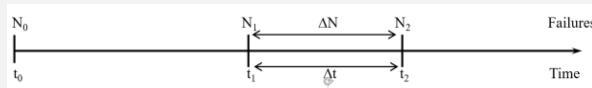
**N<sub>0</sub>** – number of failures at  $t_0$  (generally equal to 0)

**N<sub>1</sub>** – number of failures at  $t_1$

**N<sub>2</sub>** – number of failures at  $t_2$

**DN** – number of failures on the interval  $[t_1, t_2]$

**Dt** – time interval  $[t_1, t_2]$



Reliability function estimators depend on the value of N (number of products put into operation)

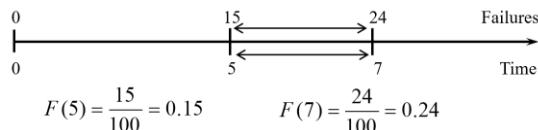
Estimator	N
Median ranks if $1 < N \leq 20$	$1 < N \leq 20$
Average ranks if $20 < N \leq 50$	$20 < N \leq 50$
Cumulative frequencies if $N > 50$	$N > 50$

### Failure Estimators: F(t)

Point estimator at time t

Median ranks if $1 < N \leq 20$	$F(t) = \frac{N_t - 0.3}{N + 0.4}$
Average ranks if $20 < N \leq 50$	$F(t) = \frac{N_t}{N + 1}$
Cumulative frequencies if $N > 50$	$F(t) = \frac{N_t}{N}$

Example (N = 100) → Cumulative frequencies



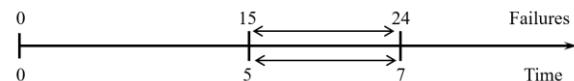
### Reliability Estimators: R(t)

Point estimator at time t

Whatever the value of N, first compute the estimator of F and then apply the complementarity relation

$$R(t) = 1 - F(t)$$

Example (N = 100)



$$R(5) = 1 - 0.15 = 0.85$$

$$R(5) = \frac{100 - 15}{100} = 0.85$$

$$R(7) = 1 - 0.24 = 0.76$$

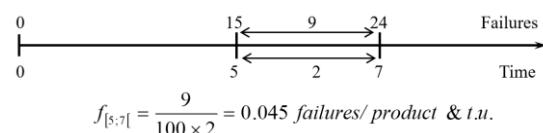
$$R(7) = \frac{100 - 24}{100} = 0.76$$

### Density estimators: f(t)

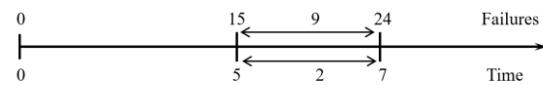
Estimator on interval estimator (failure/product and unit of time)

Median ranks if $1 < N \leq 20$	$f_{[t1;t2]} = \frac{\Delta N}{(N + 0.4) \times \Delta t}$
Average ranks if $20 < N \leq 50$	$f_{[t1;t2]} = \frac{\Delta N}{(N + 1) \times \Delta t}$
Cumulative frequencies if $N > 50$	$f_{[t1;t2]} = \frac{\Delta N}{N \times \Delta t}$

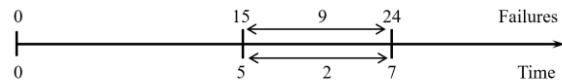
Example (with N = 100)



$$f_{[5;7]} = \frac{9}{100 \times 2} = 0.045 \text{ failures/product \& t.u.}$$



$$\lambda_{[5;7]} = \frac{9}{85 \times 2} = 0.053 \text{ failures/product \& t.u.}$$



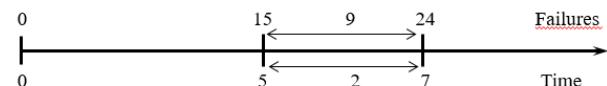
$$E(t)_{[5;7]} = \frac{1}{0.053} = \frac{85 \times 2}{9} = 18.89 \text{ u.t.}$$

### Failure Rate Estimators: λ(t)

Estimator on interval estimator (failure/product and unit of time)

Median ranks if $1 < N \leq 20$	$\lambda_{[t1;t2]} = \frac{\Delta N}{(N + 0.7 - N_1) \times \Delta t}$
Average ranks if $20 < N \leq 50$	$\lambda_{[t1;t2]} = \frac{\Delta N}{(N + 1 - N_1) \times \Delta t}$
Cumulative frequencies if $N > 50$	$\lambda_{[t1;t2]} = \frac{\Delta N}{(N - N_1) \times \Delta t}$

Example (with N = 100)



$$\lambda_{[5;7]} = \frac{9}{85 \times 2} = 0.053 \text{ failures/product \& t.u.}$$

## Predictive Reliability

**Predictive reliability** (predicted or theoretical) is calculated on the basis of a mathematical model defined from the functional decomposition of the system into subsets, components, etc. and the estimated or predicted reliability of its components. The analysis and calculation steps are usually the following:

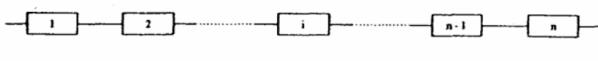
- Decompose the system into components (parts, subsystems ...) and establish the functional links between the components
- Identify component reliability models or collect reliability at a given time
- Search for a model of the system and calculate its reliability

## Reliability block diagram (RBD)

A reliability block diagram is a success-oriented network describing the function of the system. It shows the logical connections of (functioning) components needed to fulfill a specified system function

## Series Structure

In a series configuration, a failure of any component results in the failure of the entire system. Since the components are **independent**, the corresponding reliability block diagram is:



*Schematic illustration of a series system*

In other words, for a pure series system, if there are  $n$  components in series, where the reliabilities are independent of the  $i$ -th component is denoted by  $R_i$ , the system reliability is:

$$R_s = R_1 \times R_2 \times \dots \times R_n = \prod_{i=1}^n R_i$$

i.e. the system reliability is equal to the product of the reliabilities of its constituent components.

### Example

An electronic system has 1000 components in reliability series. The reliability of each component is 0.999. Determine System reliability.

### Solution

$$R_s = \prod_{i=1}^{1000} 0.999 = (0.999)^{1000} = 0.368$$

### Commentary

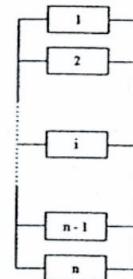
1. Even though a component reliability of 0.999 sounds good, the sheer number of these components causes a low system reliability.

2. Even though 0.999~1.0, the difference is crucial. For high reliability values, the probability of failure often gives a clearer picture. For example, increasing the component reliability from 0.999 to 0.9999 requires a ten-fold reduction of the failure probability.

## Parallel Structure

The reliability of a system containing independent subsystems can usually be increased by using subsystems in a redundant way.

If the components are in parallel, system performs if any one component remains operational. The corresponding reliability block diagram is:



*Schematic illustration of a parallel system*

If there are  $n$  components in parallel, where the probability of failure of the  $i$ -th component is denoted by  $F_i$ , the probability of system failure is:

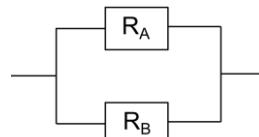
$$F_s = F_1 \times F_2 \times \dots \times F_n = \prod_{i=1}^n F_i$$

the system reliability is then:

$$R_s = 1 - \prod_{i=1}^n F_i = 1 - \prod_{i=1}^n (1 - R_i)$$

This model assumes that there is statistical independence among failures of the subsystems. This assumption is important because dependence between subsystems can have a significant effect on system reliability.

*Example for 2 parallel subsystems :*



$$R_s = R_A + R_B - R_A \times R_B$$

## Redundancy

Redundancy is the surest method of preventing system failure. There are four kinds of redundancy: diverse, homogenous, active, and passive.

Active redundancy guards against both system and element failure. It also allows for element failure, repair, and substitution with minimal disruption of system performance.

Passive redundancy is ideal for noncritical elements, but it will result in system failure when used for elements critical to system operation. Passive redundancy is the simplest and most common kind of redundancy.

Diverse redundancy is resistant to a single cause of failure, but is complex to implement and maintain. For the train, a single cause is unlikely to result in a cascade failure in all three braking systems.

Homogenous redundancy is relatively simple to implement and maintain but is susceptible to single causes of failure — i.e., the type of the cause that results in failure in one element can result in failure of other redundant elements.

Use diverse redundancy for critical systems when the probable causes of failure cannot be anticipated. Use homogenous redundancy when the probable causes of failure can be anticipated. Use active redundancy for critical systems that must maintain stable performance in the event of element failure or extreme changes in system load. Use passive redundancy for noncritical elements within systems, or systems in which performance interruptions are tolerable.

## Important Terms

**Redundancy** – Use of more elements than necessary to maintain the performance of a system in the event of failure of one or more of the elements.

**Active Redundancy** – Application of redundant elements at all times (e.g., using multiple independent pillars to support a roof). All components are active from the start. Only one component working allows the functioning of the whole system.

**Passive Redundancy** – Application of redundant elements only when an active element fails (e.g., using a spare tire on a vehicle in the event of a flat tire). Only the first component is activated. If it fails, then the second component is activated. The whole system fails when the last component fails.

**Diverse Redundancy** – use of multiple elements of different types (e.g., high-speed trains often have diverse redundancy in their braking systems—one electric brake, one hydraulic brake, and one pneumatic brake)

**Homogenous Redundancy** – Use of multiple elements of a single type (e.g., use of multiple independent strands to compose a rope).

## K-out-N redundancy system

A system that is functioning if and only if at least k of the n components are functioning

$R_1, R_2, \dots, R_n$  are the elementary independent reliabilities of the components of the system at a given time.

$$R_S = \sum_{i=k}^n (C_n^i \cdot R^i \cdot (1-R)^{n-i})$$

n: total number of components

R: reliability of a component

k: number of components to operate simultaneously

with:  $C_n^k = \frac{n!}{k!(n-k)!}$



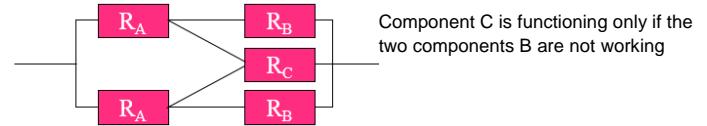
This relation (using binomial law) is applicable only if the R are identical, otherwise, application of the truth table.

## Truth table

$R_A, R_B$  and  $R_C$  are different

A	B	C	Output
0	0	0	0
0	0	1	0
0	1	0	0
0	1	1	$F_A \times R_B \times R_C = (1-R_A) \times R_B \times R_C$
1	0	0	0
1	0	1	$R_A \times F_B \times R_C = R_A \times (1-R_B) \times R_C$
1	1	0	$R_A \times R_B \times F_C = R_A \times R_B \times (1-R_C)$
1	1	1	$R_A \times R_B \times R_C$
$\sum$			$R_S = (1-R_A)R_BR_C + R_A(1-R_B)R_C + R_A R_B (1-R_C) + R_A R_B R_C$

## Complex system

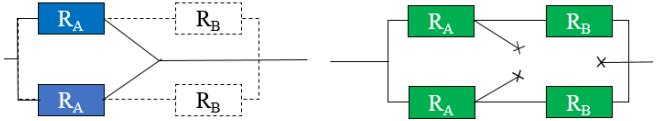


Decomposition Method (Baye's theorem) :

In this method a keystone component is chosen. This keystone element can have only two states, good or bad. When keystone is good it is shorted and when keystone is bad then it is opened. A reduced series parallel system is obtained. Then the reliability of the reduced systems is obtained by methods of series parallel reliability evaluation and is multiplied by the probability of proper keystone states and added together to get system reliability.

$$P\{S\} = P\{S|C\} \times P\{C\} + P\{S|\bar{C}\} \times P\{\bar{C}\}$$

$$R(S) = (1 - (1 - R_A)^2) \times R_C + (1 - (1 - R_A \cdot R_B)^2) \times (1 - R_C)$$



We path through C, thereby bypassing B

We disconnect all the paths leading through C

## Application to the exponential model

$$R(t) = e^{(-\lambda_0 t)}$$

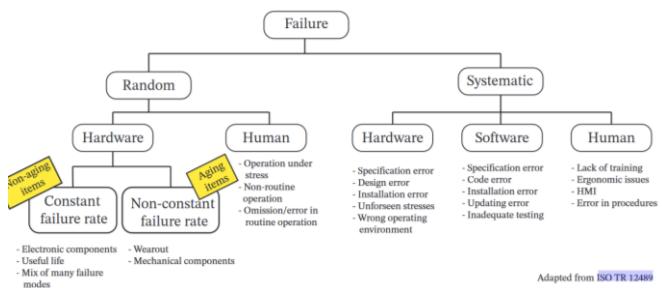
$$F(t) = 1 - e^{(-\lambda t)} \quad \text{with: } \lambda = 1/E(t) \text{ (failure rate)}$$

Serial system	$R(t) = e^{(-t \sum_{i=1}^n \lambda_i)} = e^{(-t \lambda_s)}$
Parallel system (n components)	$R(t) = 1 - \prod_{i=1}^n (1 - e^{(-\lambda_i t)})$
Parallel system (2 components)	$R(t) = e^{-\lambda_1 t} + e^{-\lambda_2 t} - e^{-(\lambda_1 + \lambda_2)t}$

## Classification of failures

**Partial:** the system has a degraded performance, but is still able to perform its essential functions.

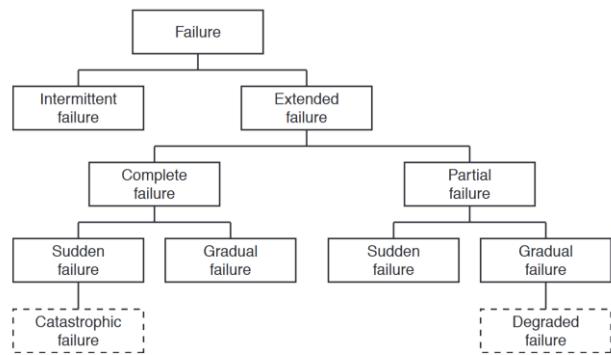
**Complete:** failure of one or several items cause immediate cessation of the system ability to perform the required function.



Failure Classification in ISO TR 12849

ISO TR 12489 adds to the category random failures, to capture that some systematic faults (induced by human errors) can be regarded as random

## Other mean of failure classifications



Failure classification (adapted from Blanche and Shrivastava 1994).

# Problems

## Worked Examples

### 1. Exponential Distribution

Assume that the mean time to failure of an engineering system is 1500 hours.

- (a) Calculate the probability of failure of the engineering system during a 500-hour mission.

### 2. Failure / Survival / Conditional Probability

The failure time ( $t$ ) of an electronic circuit board follows an exponentially distribution with failure rate  $\lambda = 10^{-4}/\text{h}$ .

- (a) What is the probability that it will fail before 1000 h ?  
(b) What is the probability that it will survive at least 10,000 h  
(c) What is the probability that it will fail between 1000 and 10,000 h ?  
(d) Suppose that the device has been successfully operated for 8000 hours. What is the probability that it will fail during the next 1500 hours of operation?

### 3. Distribution Law

The reliability data of a machine is given:

TTF (days)	0	100	200	300	400	500	600	700	900
R(t)	1	0.76	0.52	0.32	0.2	0.13	0.08	0.04	

- (a) Determine if this lifetime law follows an exponential distribution?

### 4. Weibull distribution

The following table summarizes the lifetime in hours of a sample of 9 products of the same type, used under the same conditions until failure.

Sample #	1	2	3	4	5	6	7	8	9
TTF (h)	152	245	405	310	785	500	570	660	910

- (a) Plot the 'distribution function' on a Weibull paper and find the Weibull parameters.  
(b) Express the Reliability function.  
(c) Calculate the reliability for a mission of 562.4 hours  
(d) Calculate the MTBF.

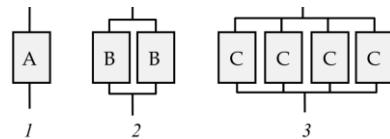
### 5. Predictive reliability: Reliability block diagram

A personal computer consists of 4 basic subsystems: motherboard (MB), hard disk (HD), power supply (PS) and processor (CPU). The reliabilities of the subsystems for a mission of 1000 hours are 0.98, 0.95, 0.91 and 0.99 respectively. All subsystems need to be functioning for the overall system success.

- (a) What is the system reliability for a mission of 1000 hours ?

### 6. Predictive reliability & Redundancy

We consider three components A, B and C of respective prices 150, 75 and 45 €. At a given moment, FA = 0.1, FB = 0.3 and FC = 0.4 the respective failures of the three components.

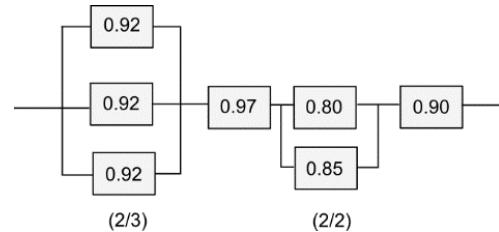


- (a) Which of the following three systems has the highest reliability?  
(b) Which of the three systems has the best reliability/price ratio?

### 7. Predictive reliability

The given values correspond to the reliability of the components at a given time.

Show that the predictive reliability of this system is Rsys = 0.583.



## Tutorials

### 8. Survival probability

What is the survival probability of an electronic device that has been working for a period of time equal to the MTTF ?

### 9. Reliability Estimators

A batch of 85 solenoid valves subjected to continuous testing at a rate of 210 pulses/minute was tested. After 45 operating hours, 17 solenoid valves have failed and after 62 hours, there are 51 solenoid valves in working order.

- (a) Estimate the failure and reliability functions for a mission duration of 45 hours.  
(b) Estimate the failure rate per hour and per solenoid valve between t=45 and t=62 hours.  
(c) Deduct the failure rate per pulse and per solenoid valve over the same interval.  
(d) Estimate the density of failure per hour and per solenoid valve between 45 and 62 hours.  
(e) Estimate the average lifetime E(t) per valve over the entire period of observation.

### 10. Reliability Estimators

18 units were subjected to a reliability test, together and under identical operating conditions. 6 hours after start of test 14 units continue to operate normally. During the next 2 hours, 2 units failed.

- (a) Estimate the failure and reliability functions for a mission duration of 6 hours  
(b) Estimate the density of failure f(t) over the interval [6 ; 8]  
(c) Estimate the failure rate over the interval [6 ; 8]

## 11. Improvement of reliability

An injection system is considered at a given time. It is composed of a pipeline of reliability  $R_p=0.98$  and a nozzle of reliability  $R_n=0.9$

- (a) Calculate the reliability of the system
- (b) A group of experts considers that the failure of the injection system is too high. It is then decided to improve its reliability by adding a redundant injection system. Calculate the new system reliability.
- (c) The reliability is always considered insufficient, a 3rd nozzle is added which only works if the others are failing. What would be the reliability of the third nozzle, if the reliability of the system were to be 0.999?

## 12. Modelling Reliability

Consider at a given moment a system formed by the following components:

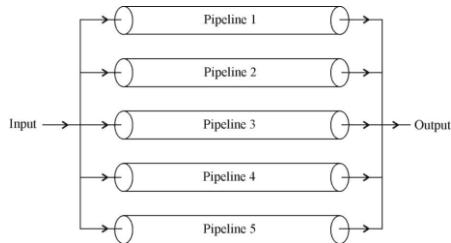
- 2 diodes, each having a reliability  $R_d = 0.9$
- 1 engine having a reliability  $R_m = 0.8$
- 1 amplifier having a reliability  $R_a = 0.9$
- 1 preamplifier having a reliability  $R_{pa} = 0.92$

The diodes must provide a voltage to the engine with amplification using the amplifier and preamplifier. The system can operate with a single diode, but a failure of the engine, preamplifier or amplifier will cause the system to fail.

- (a) Plot the reliability diagram of this system and calculate its reliability.
- (b) What type of failure is it if a diode fails? Engine fails?
- (c) A saving would be appreciable if we use cheaper diodes of reliability  $R_d = 0.8$ . Can we accept this solution if the reliability of the system should not fall by more than 5%?

## 13. Predictive reliability: Redundancy

Consider a piping system having 5 pipes connected in parallel as shown in the figure below. Assume that all pipes are identical and independent. The system is said to work successfully if at least 3 pipelines perform their intended function successfully.



If reliability of smooth flow of the liquid from each pipeline is 0.80 for a mission of 1 year, evaluate the reliability of the system working successfully.

## 14. Conditional Reliability

A CPU fan has a constant failure rate  $\lambda = 2.45 \cdot 10^{-4}$  days<sup>-1</sup>

- (a) Calculate the probability that the pump survives 4500 days in continuous operation.
- (b) Suppose that the fan has been functioning without failure during its first 3000 days in operation. Calculate the probability that the pump will fail during the next 950 days.

## 15. Failure rate

A 5-ton truck has a MTBF of 1,750 miles when used in cross country terrain. Assuming constant failure rate, what is the reliability for a 75-mile mission?

## 16. Failure rate

A sighting system consists of a north seeking gyro, laser designator, A/D converter, digital computer, and transmitter. This entire system is assumed to have an exponential distributed time-to-failure with a mean of 130 hours.

- (a) What is the failure rate for the system?
- (b) What is the probability that the system were surviving 10 hours of use?
- (c) How long can the system be used such that there is 90% reliability?

## 17. Fail / Survival probability

A power electronic component has a constant failure rate of 0.333 per 1000 hours of operation (one failure every 3000 hours).

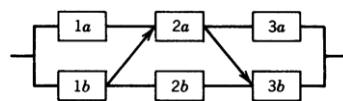
- (a) What is the probability that a component will survive after 3000 hours?
- (b) What is the probability that the component will last between 1000 and 3000 hours?
- (c) What is the probability that the component will last another 1000 hours after 3000 hours of operation?

## 18. Failure rate

The reliability service of a given vehicle brand, reported 15 failures on a 45-car lot followed during the period of 80,000 to 90,000 km.

- (a) Calculate the failure rate per vehicle and per km estimated over that period.
- (b) Deduct the average duration between two failures estimated over this period.

## 19. Reliability of complex system



$$\begin{aligned} R_{1a} &= R_{2b} \\ R_{2a} &= R_{2b} \\ R_{3a} &= R_{3b} \end{aligned}$$

Calculate the reliability of the system